

## Single P-Channel MOSFET

### ■ DESCRIPTION

SMC2337S is the P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced trench technology devices are well suited for high efficiency fast switching applications, low in-line power loss needed in small outline surface mount package.

### ■ PART NUMBER INFORMATION

**SMC 2337 S - TR G**

a	b	c	d	e
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a : Company name.  
 b : Product Serial number.  
 c : Package code      S: SOT-23L  
 d : Handling code      TR: Tape&Reel  
 e : Green produce code G: *RoHS Compliant*

### ■ FEATURES

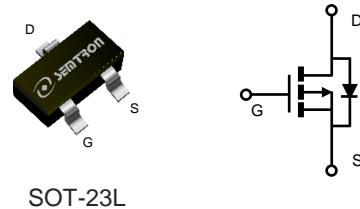
**$V_{DS}=-20V$ ,  $I_D=-6.7A$**

$R_{DS(ON)}=17m\Omega$ (Typ.)@ $V_{GS}=-10V$   
 $R_{DS(ON)}=19m\Omega$ (Typ.)@ $V_{GS}=-4.5V$   
 $R_{DS(ON)}=23m\Omega$ (Typ.)@ $V_{GS}=-2.5V$   
 $R_{DS(ON)}=29m\Omega$ (Typ.)@ $V_{GS}=-1.8V$

◆ 1.8V Low gate drive applications

### ■ APPLICATIONS

- ◆ Portable Equipment
- ◆ Battery Protection
- ◆ Power Management



SOT-23L

### ■ ABSOLUTE MAXIMUM RATINGS ( $T_A=25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-20	V
$V_{GS}$	Gate-Source Voltage	$\pm 12$	V
$I_D$	Continuous Drain Current <sup>A</sup> ( $V_{GS}=4.5V$ )	-6.7	A
	$T_A=25^\circ C$	-6.7	A
	$T_A=70^\circ C$	-5.3	A
$I_{DM}$	Pulsed Drain Current <sup>B</sup>	-26.8	A
$I_{AS}$	Avalanche Current <sup>B</sup>	16	A
$E_{AS}$	Single Pulse Avalanche energy $L=0.1mH$ <sup>B</sup>	12.8	mJ
$P_D$	Power Dissipation <sup>A</sup>	1.6	W
	$T_A=25^\circ C$	1.6	W
	$T_A=70^\circ C$	1	W
$T_J$	Operation Junction Temperature	-55/150	°C
$T_{STG}$	Storage Temperature Range	-55/150	°C

### ■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient <sup>A</sup> $t \leq 10s$		80	°C/W
	Thermal Resistance Junction to Ambient <sup>AC</sup> Steady-State		120	

**ELECTRICAL CHARACTERISTICS (TA=25°C Unless otherwise noted)**

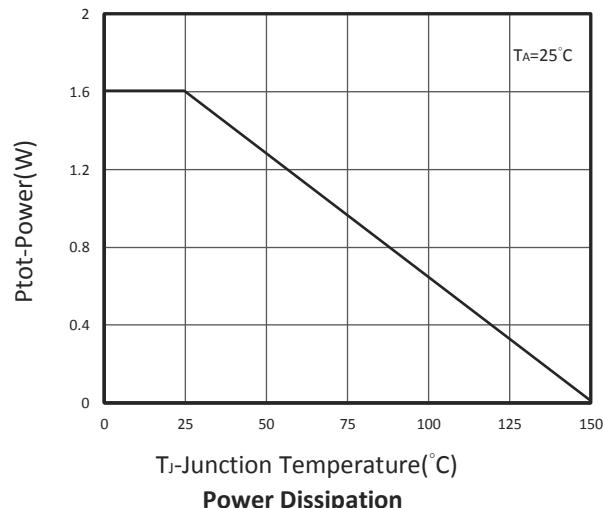
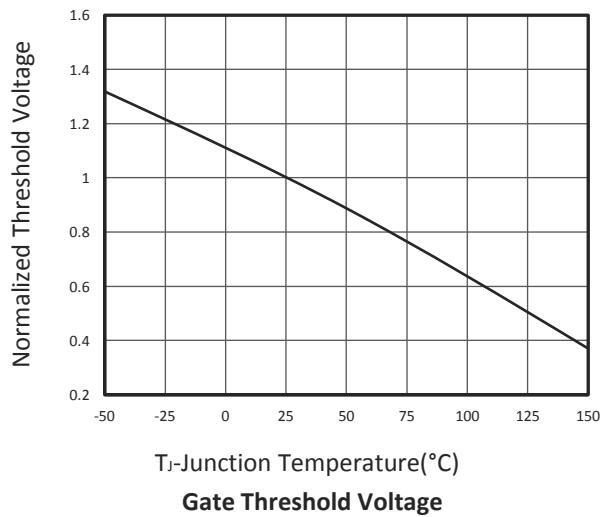
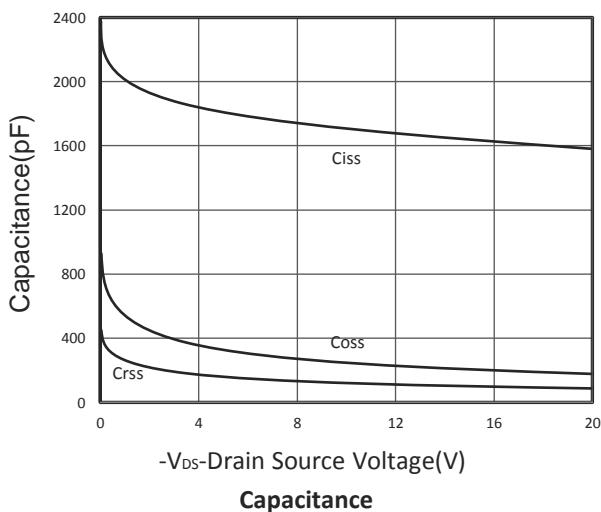
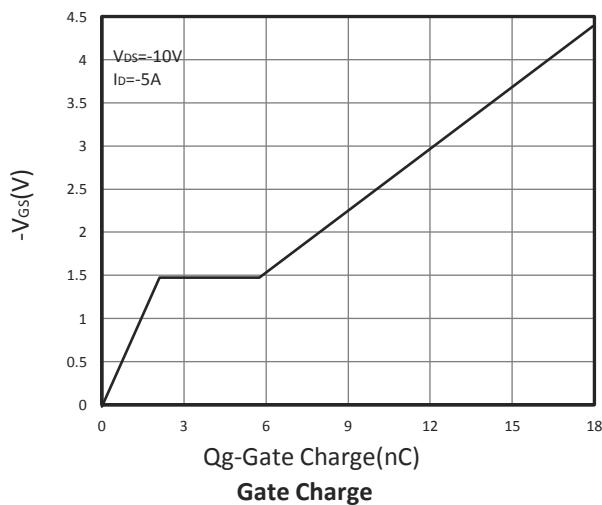
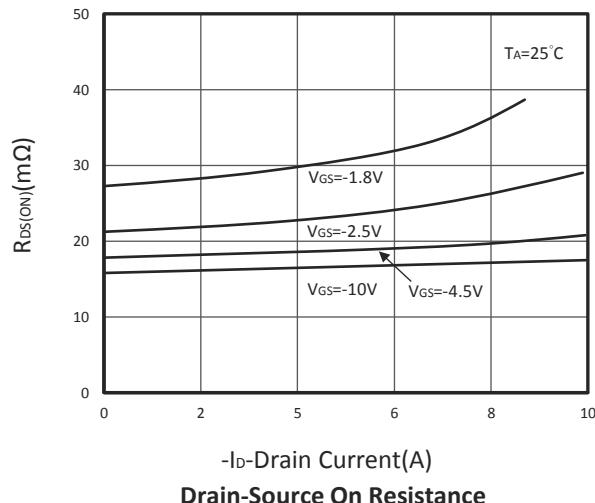
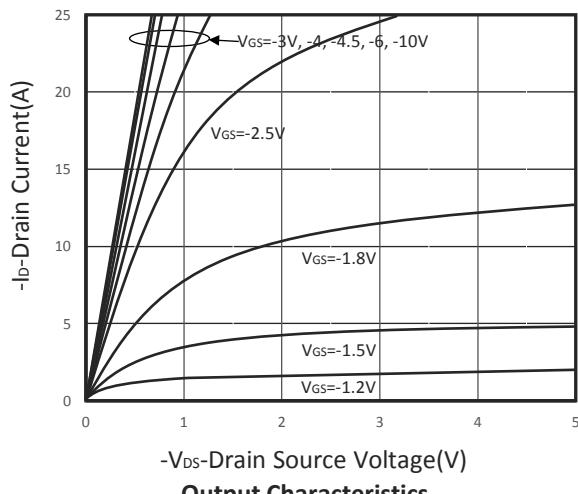
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
<b>Static Parameters</b>							
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	-20			V	
V <sub>G(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-0.4	-0.6	-1	V	
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V			±100	nA	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C			-1	μA	
		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V, T <sub>J</sub> =75°C			-10		
R <sub>D(on)</sub>	Drain-source On-Resistance <sup>D</sup>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-6.7A V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-5A V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-4A V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-3A	17 19 23 29	20 22 27 35		mΩ	
G <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-10V, I <sub>D</sub> =-5A		17		S	
<b>Diode Characteristics</b>							
V <sub>SD</sub>	Diode Forward Voltage <sup>D</sup>	I <sub>s</sub> =-1A, V <sub>GS</sub> =0V			-1	V	
I <sub>s</sub>	Diode Continuous Forward Current				-3.4	A	
<b>Dynamic and Switching Parameters <sup>E</sup></b>							
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =-10V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-5A		19	26.6	nC	
Q <sub>gs</sub>	Gate-Source Charge			2.1	2.9		
Q <sub>gd</sub>	Gate-Drain Charge			3.8	5.3		
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-10V, V <sub>GS</sub> =0V, f=1MHz		1680		pF	
C <sub>oss</sub>	Output Capacitance			228			
C <sub>rss</sub>	Reverse Transfer Capacitance			115			
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =-10V, V <sub>GEN</sub> =-4.5V R <sub>G</sub> =10Ω, I <sub>D</sub> =-1A		10	19	ns	
t <sub>r</sub>				38	72		
t <sub>d(off)</sub>	Turn-Off Time			86	163		
t <sub>f</sub>				25	48		

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

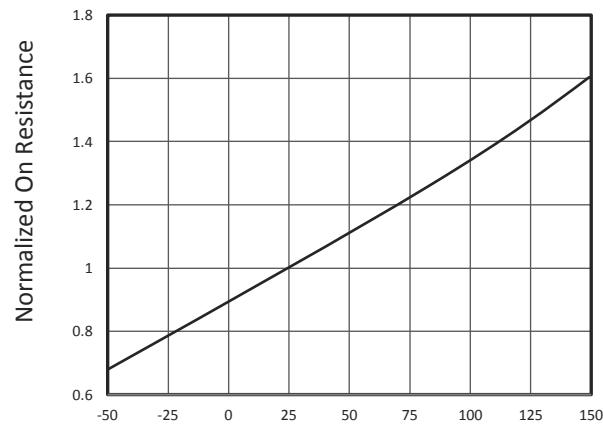
- A. Surface mounted on FR4 board using 1 in<sup>2</sup> pad size.
- B. Pulsed width limited by maximum junction temperature, T<sub>J(MAX)</sub>=150°C (initial temperature T<sub>J</sub>=25°C).
- C. Using ≤ 10s junction-to-ambient thermal resistance is base on T<sub>J(MAX)</sub>=150°C.
- D. Pulse test width ≤300μs and duty cycle ≤ 2%.
- E. Guaranteed by design, not subject to production testing.

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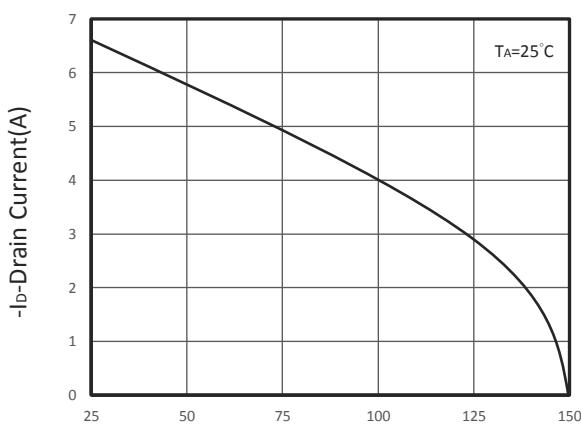
## TYPICAL CHARACTERISTICS



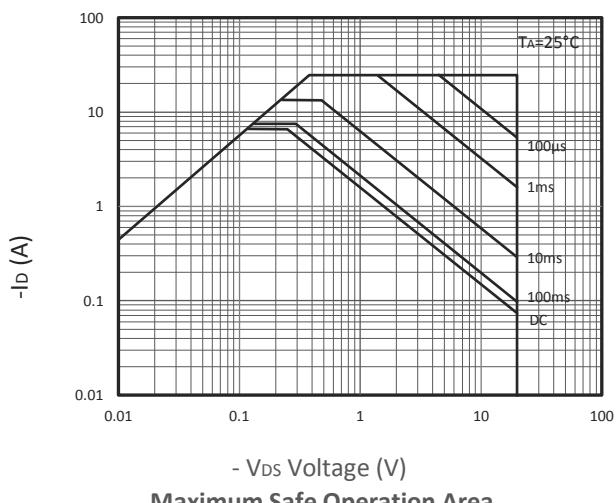
## TYPICAL CHARACTERISTICS



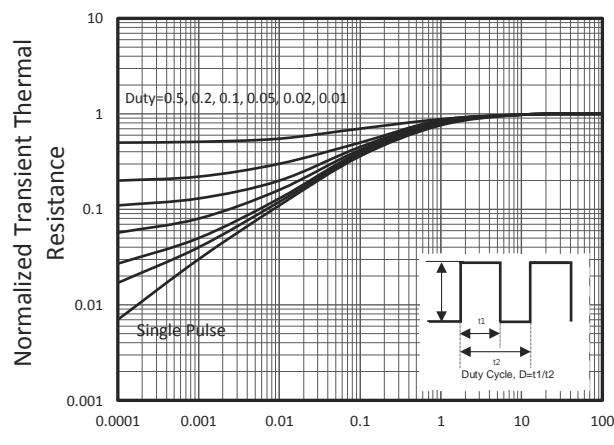
$T_J$ -Junction Temperature(°C)  
 $R_{DS(ON)}$  vs Junction Temperature



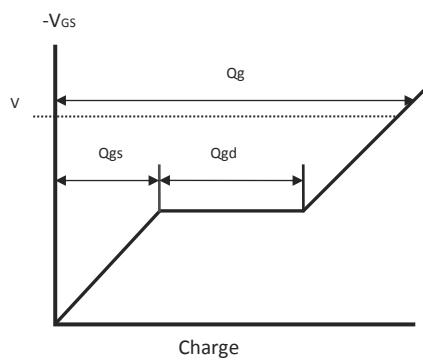
$T_J$ -Junction Temperature(°C)  
Drain Current vs  $T_J$



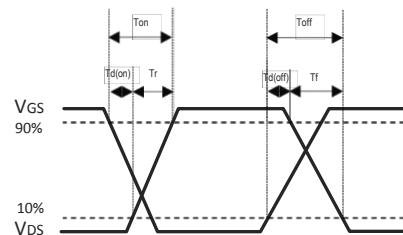
$-V_{DS}$  Voltage (V)  
Maximum Safe Operation Area



Square Wave Pulse Duration(Sec)  
Thermal Transient Impedance

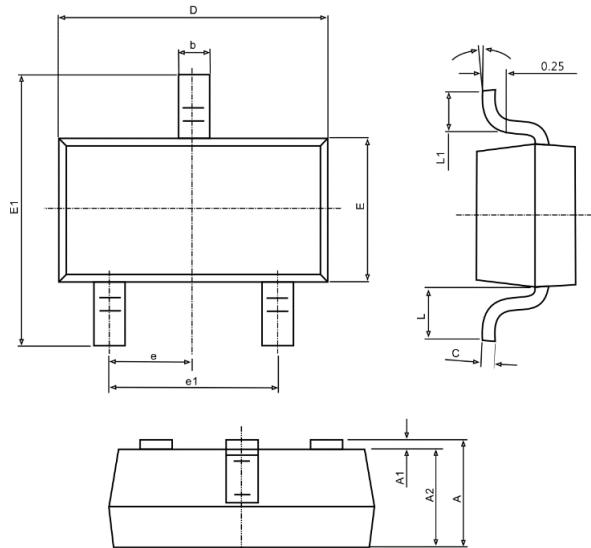


Gate Charge Waveform

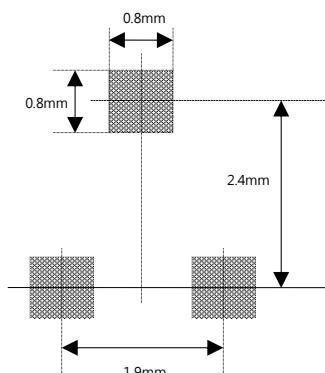


Switching Time Waveform

## SOT-23L PACKAGE DIMENSIONS



Recommended Minimum Pad(mm)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.000	1.300	0.039	0.049
A1	0.000	0.100	0.000	0.004
A2	1.000	1.200	0.039	0.047
b	0.300	0.500	0.012	0.020
c	0.047	0.207	0.002	0.008
D	2.800	3.000	0.110	0.118
E	1.500	1.700	0.059	0.067
E1	2.600	3.000	0.102	0.118
e	0.950 TYP.		0.037 TYP.	
e1	1.900 TYP.		0.075 TYP.	
L1	0.250	0.550	0.010	0.022
θ	0°	8°	0°	8°